

# RELIABILITY MONITOR

PRODUCT	MONITOR DATE	DATE CODE	ASSEMBLY FACILITY	ASSEMBLY LOT NO	PROCESS TYPE	PACKAGE TYPE
DS21S07A	Aug-97	9720 B2	CARSEM	DM709276AAA	0.8μ NITRIDE	20 TSSOP

**STRESS/JOB NO.**

**READPOINT  
(Sample Size/No. of Fails)**

Preconditioning (P/C):  
HTC Vapor Phase  
P-20241

<u>Electrical</u>	<u>Cum %</u>
235/0	0.0%

Sonoscan  
P-20288

<u>Post Vapor Phase</u>
4/0

Infant / High Voltage Life  
125°C, 7.0 V.  
P-20289, P-20377

<u>48 Hr</u>	<u>336 Hr</u>	<u>1KHr</u>	<u>*Failure Rate</u>
231/0	77/0		

\*Chi Squared Method, 60% C. L., 55°C & 5.5V; Temperature Derating: Ea = 0.7 ev; Voltage Derating B = 1.0

Temp Cycle  
-55°C to +125°C  
P-20378

<u>300 ~</u>	<u>1K ~</u>	<u>Cum %</u>
39/0		

Biased Moisture  
85°C/85% RH, 5.5 V.  
P-20379

<u>274 Hr</u>	<u>959 Hr</u>	<u>Cum %</u>
77/0		

Autoclave  
121°C/100% RH, 2 Atmos  
P-20380

<u>96 Hr</u>	<u>Cum %</u>
38/0	0.0%

**Failure Mode**

**Failure Analysis**